

**Notice of References Cited**

Application/Control No.

10/756,716

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner

Clement N. Tedom

Art Unit

2609

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0141349	10-2002	Kim et al.	370/252
*	B	US-2003/0093364	05-2003	Bae et al.	705/37
*	C	US-6,671,266	12-2003	Moon et al.	370/342
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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